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With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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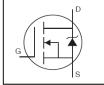


Source

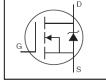
HEXFET® Power MOSFET



- Logic -Level Gate Drive
- Advanced Process Technology
- Isolated Package
- High Voltage Isolation = 2.5KVRMS ©
- Sink to Lead Creepage Dist. = 4.8mm
- Fully Avalanche Rated
- Lead-Free



$V_{ t DSS}$	100V
R _{DS(on)}	0.10Ω
I _D	12A



Gate

G		D	S
	Т	O-220 Full-Pak	
		D S	

Drain

Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low onresistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-220 Fullpak eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The Fullpak is mounted to a heatsink using a single clip or by a single screw fixing.

Base Part Number Package Type		Standar	Ordereble Dort Number	
base Part Number	Package Type	Form	Quantity	Orderable Part Number
IRLI530NPbF	TO-220 Full-Pak	Tube	50	IRLI530NPbF

Absolute Maximum Ratings					
Symbol	Parameter	Max.	Units		
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	12			
_D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	8.6	Α		
DM	Pulsed Drain Current ①⑥	60			
P _D @T _C = 25°C	Maximum Power Dissipation	41	W		
	Linear Derating Factor	0.27	W/°C		
V_{GS}	Gate-to-Source Voltage	± 16	V		
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②⑥	150	mJ		
AR	Avalanche Current ①⑥	9.0	А		
= AR	Repetitive Avalanche Energy ①	4.1	mJ		
dv/dt	Peak Diode Recovery dv/dt36	5.0	V/ns		
Γ _J	Operating Junction and	-55 to + 175			
T_{STG}	Storage Temperature Range		°C		
	Soldering Temperature, for 10 seconds (1.6mm from case)	300			
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)			

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ hetaJC}$	Junction-to-Case		3.7	°C/W
$R_{ heta JA}$	Junction-to-Ambient		65	C/VV

2017-04-27



Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.122		V/°C	Reference to 25°C, I _D = 1mA ©
, ,				0.100		V _{GS} = 10V, I _D = 9.0A
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.120		$V_{GS} = 5.0V, I_D = 9.0A$
26(6)				0.150	-	V _{GS} = 4.0V, I _D = 8.0A
$V_{GS(th)}$	Gate Threshold Voltage	1.0		2.0		$V_{DS} = V_{GS}, I_D = 250 \mu A$
gfs	Forward Trans conductance	7.7				V _{DS} = 50V, I _D = 9.0A®
	Drain to Course Leakens Current			25		V _{DS} = 100V, V _{GS} = 0V
I _{DSS}	Drain-to-Source Leakage Current			250	μΑ	$V_{DS} = 80V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
1	Gate-to-Source Forward Leakage			100	nA	V _{GS} = 16V
I _{GSS}	Gate-to-Source Reverse Leakage			-100	IIA	$V_{GS} = -16V$
Qg	Total Gate Charge			34		$I_{D} = 9.0A$
Q_gs	Gate-to-Source Charge			4.8	nC	V _{DS} = 80V
Q_{gd}	Gate-to-Drain Charge			20		V _{GS} = 5.0V , See Fig. 6 and 13④⑥
$t_{d(on)}$	Turn-On Delay Time		7.2			$V_{DD} = 50V$
t _r	Rise Time		53			$I_{D} = 9.0A$
$t_{d(off)}$	Turn-Off Delay Time		30		ns	R_{G} = 6.0 Ω , V_{GS} = 5.0 V
t _f	Fall Time		26			R _D = 5.5Ω, See Fig. 10④⑥
L _D	Internal Drain Inductance		4.5			Between lead, 6mm (0.25in.)
Ls	Internal Source Inductance		7.5			from package and center of die contact
C _{iss}	Input Capacitance		800			V _{GS} = 0V
C _{oss}	Output Capacitance		160		הר	V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		90		pF	f = 1.0MHz, See Fig. 5®
С	Drain to Sink Capacitance		12			f = 1.0MHz

Source-Drain Ratings and Characteristics

C G G G G	ourse Prain rainings and sharasteriorist					
	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current (Body Diode)			12		MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ① ©			60		integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 6.6A, V_{GS} = 0V $ ④
t _{rr}	Reverse Recovery Time		140	210	ns	$T_J = 25^{\circ}C$, $I_F = 9.0A$
Q _{rr}	Reverse Recovery Charge		740	1100	nC	di/dt = 100A/µs ④⑥
t _{on}	Forward Turn-On Time	Intrinsio	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)			

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Starting $T_J = 25^{\circ}C$, L = 3.1mH, $R_G = 25\Omega$, $I_{AS} = 9.0A$ (See fig. 12)
- $\label{eq:local_special} \mbox{\Im} \quad \mbox{$I_{SD} \leq 9.0$A, di/dt} \leq 540 \mbox{A/μs, $V_{DD} \leq V_{(BR)DSS}$, $T_J \leq 175^{\circ}$C. }$
- 4 Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.
- ⑤ t=60s, f=60Hz
- © Uses IRL530N data and test conditions.

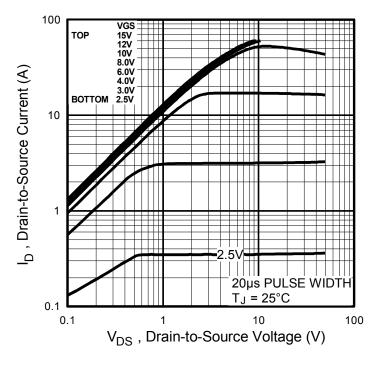


Fig. 1 Typical Output Characteristics

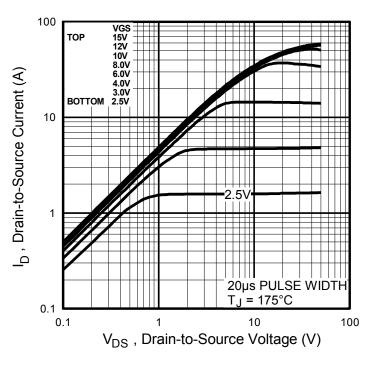


Fig. 2 Typical Output Characteristics

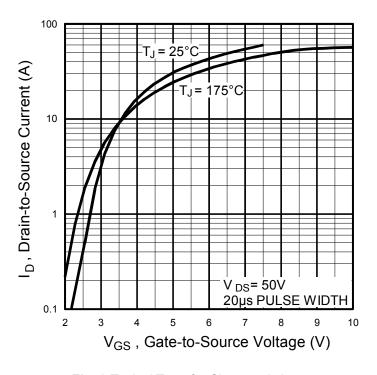


Fig. 3 Typical Transfer Characteristics

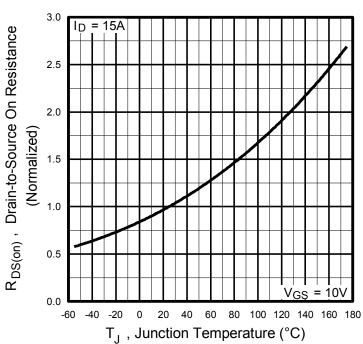


Fig. 4 Normalized On-Resistance vs. Temperature



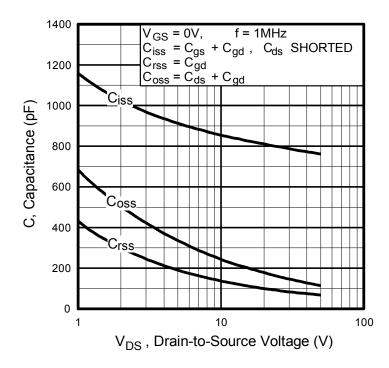


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

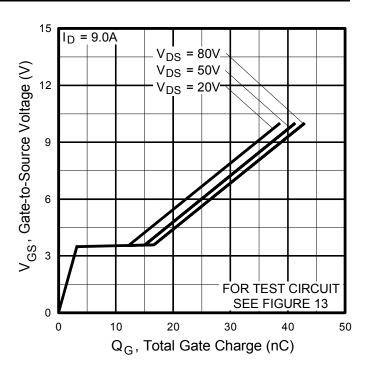


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

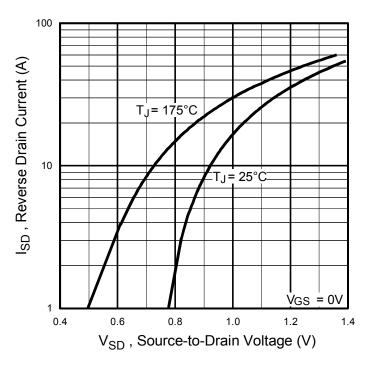


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

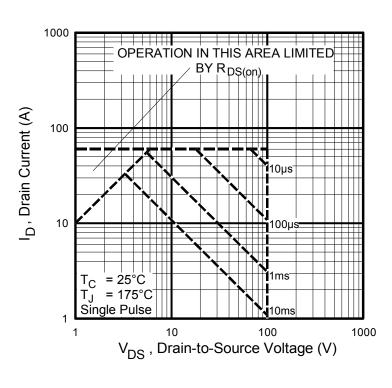


Fig 8. Maximum Safe Operating Area



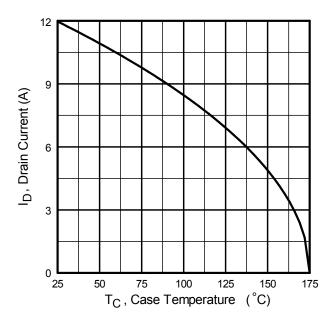


Fig 9. Maximum Drain Current vs. Case Temperature

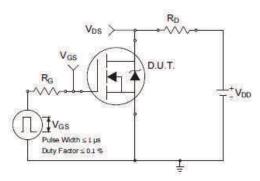


Fig 10a. Switching Time Test Circuit

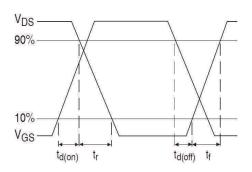


Fig 10b. Switching Time Waveforms

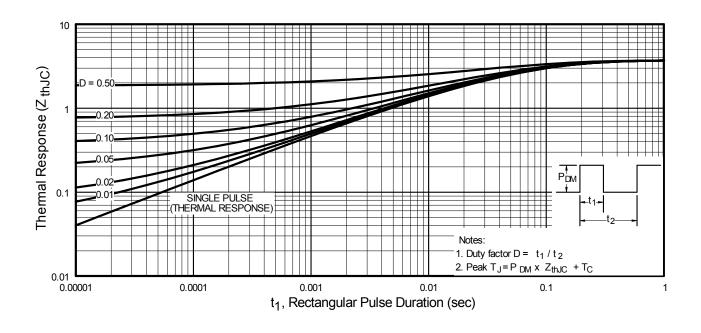


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



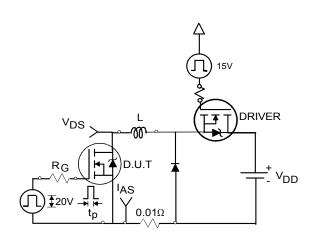


Fig 12a. Unclamped Inductive Test Circuit

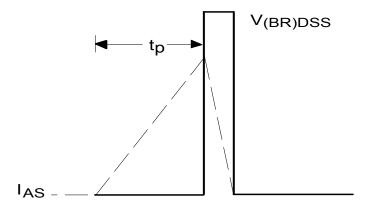


Fig 12b. Unclamped Inductive Waveforms

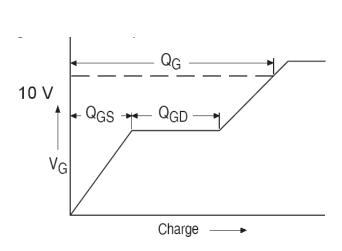


Fig 13a. Gate Charge Waveform

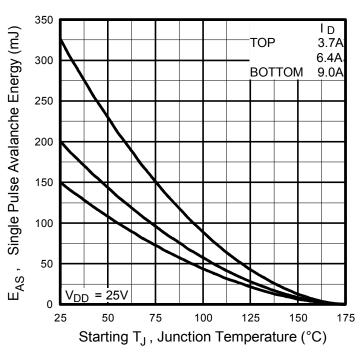


Fig 12c. Maximum Avalanche Energy vs. Drain Current

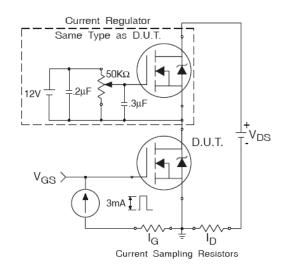
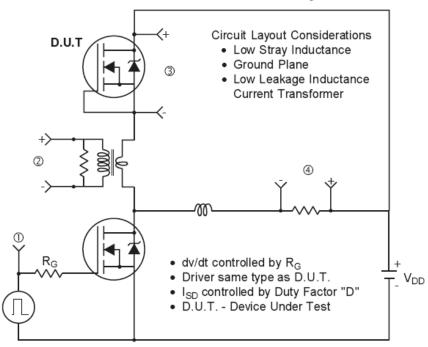


Fig 13b. Gate Charge Test Circuit

2017-04-27



Peak Diode Recovery dv/dt Test Circuit



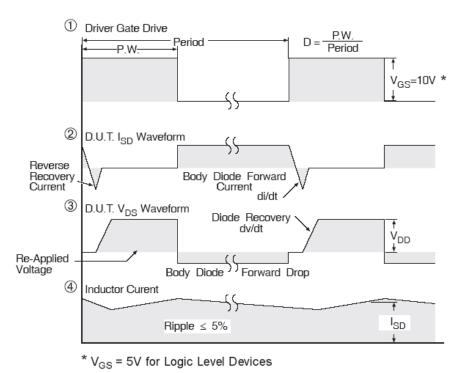
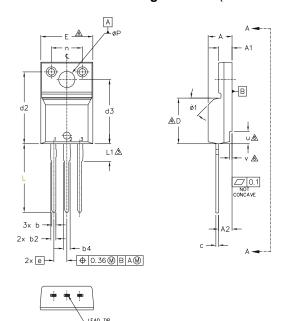
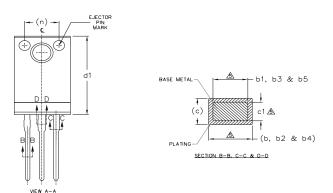


Fig 14. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs



TO-220 Full-Pak Package Outline (Dimensions are shown in millimeters (inches))





NOTES:

1.0 DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994.

DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTER MOST EXTREMES OF THE PLASTIC BODY.

DIMENSION 61, 63, 65 & c1 APPLY TO BASE METAL ONLY.

STEP OPTIONAL ON PLASTIC BODY DEFINED BY DIMENSIONS u & v.

CONTROLLING DIMENSION: INCHES.

S						
Y M	DIMENSIONS				N	
B	MILLIM	ETERS	INC	HES	Ī	
٥	MIN.	MAX.	MIN.	MAX.	S	
Α	4.57	4.83	.180	.190		
A1	2.57	2.82	.101	.111		
A2	2.51	2.92	.099	.115		<u>LEAD ASSI</u>
ь	0.61	0.94	.024	.037		
ь1	0.61	0.89	.024	.035	5	<u>HEXI</u>
b2	0.76	1.27	.030	.050		1 GA
ь3	0.76	1.22	.030	.048	5	
b4	1.02	1.52	.040	.060		2 DR
ь5	1.02	1.47	.040	.058	5	3 SO
С	0.33	0.63	.013	.025		
с1	0.33	0.58	.013	.023	5	
D	8.66	9.80	.341	.386	4	
d1	15.80	16.13	.622	.635		
d2	13.97	14.22	.550	.560		1007
d3	12.29	12.93	.484	.509		<u>IGBTs, C</u>
Ε	9.63	10.74	.379	.423	4	1 GA
е	2.54		.100	BSC		2 CO
			.520			
L1			.122		3	3 EM
n						
ØΡ		3.45		.136		
u						
V	0.41		.016		6	
Ø1	_	45°	_	45°		
	A A1 A2 b b1 b2 b3 b4 b5 c c1 D d1 d2 d3 E e L1 n øP u	M B O L MIN. A 4.57 A1 2.57 A2 2.51 b 0.61 b1 0.61 b2 0.76 b3 0.76 b4 1.02 c 0.33 c1 0.33 D 8.66 d1 15.80 d2 13.97 d3 12.29 E 9.63 e 2.54 L 13.21 L1 3.10 n 6.05 øP 3.05 u 2.39 v 0.41	M B O L MIN. MAX. A 4.57 4.83 A1 2.57 2.82 A2 2.51 2.92 b 0.61 0.94 b1 0.61 0.89 b2 0.76 1.27 b3 0.76 1.22 b4 1.02 1.52 b5 1.02 1.47 c 0.33 0.63 c1 0.33 0.58 D 8.66 9.80 d1 15.80 16.13 d2 13.97 14.22 d3 12.29 12.93 E 9.63 10.74 e 2.54 BSC L 13.21 13.72 L1 3.10 3.68 n 6.05 6.60 ØP 3.05 3.45 u 2.39 2.49 v 0.41 0.51	M B O L MILLIMETERS INCI MIN. MAX. MIN. A1 2.57 2.82 .101 A2 2.51 2.92 .099 b 0.61 0.89 .024 b1 0.61 0.89 .024 b2 0.76 1.27 .030 b4 1.02 1.52 .040 b5 1.02 1.47 .040 c 0.33 0.63 .013 c1 0.33 0.58 .013 D 8.66 9.80 .341 d1 15.80 16.13 .622 d3 12.29 12.93 .484 E 9.63 10.74 .379 e 2.54 BSC .100 L 13.21 13.72 .520 L1 3.10 3.68 .122 oP 3.05 3.45 .120 u 2.39 2.49	M B O L MILLIMETERS INCHES MIN. MAX. MIN. MAX. A1 2.57 2.82 .101 .111 A2 2.51 2.92 .099 .115 b 0.61 0.89 .024 .037 b1 0.61 0.89 .024 .035 b2 0.76 1.27 .030 .050 b3 0.76 1.22 .030 .048 b4 1.02 1.52 .040 .060 b5 1.02 1.47 .040 .058 c 0.33 0.63 .013 .025 c1 0.33 0.58 .013 .023 D 8.66 9.80 .341 .386 d1 15.80 16.13 .622 .635 d2 13.97 14.22 .550 .560 d3 12.29 12.93 .484 .509 E 9.63 <	M B O L MILLIMETERS INCHES O T E S O L MIN. MAX. MIN. MAX. A 4.57 4.83 .180 .190 A1 2.57 2.82 .101 .111 A2 2.51 2.92 .099 .115 b 0.61 0.94 .024 .037 b1 0.61 0.89 .024 .035 5 b2 0.76 1.27 .030 .050 5 b3 0.76 1.22 .030 .048 5 b4 1.02 1.52 .040 .060 5 b5 1.02 1.47 .040 .058 5 c 0.33 0.63 .013 .025 5 c1 0.33 0.58 .013 .023 5 D 8.66 9.80 .341 .386 4 d1 15.80 16.13 .622 .635 d2 13.97 14.22 .550 .560

SIGNMENTS

KFET

4 TE

RAIN

OURCE

<u>CoPACK</u>

ATE

OLLECTOR

MITTER

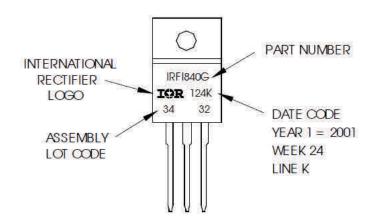
TO-220 Full-Pak Part Marking Information

EXAMPLE: THIS IS AN IRFI840G WITH ASSEMBLY

LOT CODE 3432

ASSEMBLED ON WW 24, 2001 IN THE ASSEMBLY LINE "K"

Note: "P" in assembly line position indicates "Lead-Free"



TO-220AB Full-Pak packages are not recommended for Surface Mount Application.

Note: For the most current drawing please refer to website at http://www.irf.com/package/

2017-04-27



Qualification Information

Qualification information					
Qualification Level	Industrial (per JEDEC JESD47F) †				
Moisture Sensitivity Level	TO-220 Full-Pak	N/A			
RoHS Compliant	Yes				

† Applicable version of JEDEC standard at the time of product release.

Revision History

Date	Comments			
	Changed datasheet with Infineon logo - all pages.			
04/27/2017	Corrected Package Outline on page 8.			
	Added disclaimer on last page.			

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